# Contents

Conference Photograph vi

Preface vii

Conference Information viii

**Chapter 1. Roughness at surfaces and interfaces**

Roughness of surfaces and interfaces
W. Press, M. Tolan, J. Stettner, O.H. Seeck, J.P. Schlomka, V. Nitz, L. Schwalowsky, P. Müller-Buschbaum and D. Bahr 1

Interfacial roughness of partially correlated metallic multilayers studied by non-specular X-ray reflectivity
R. Paniago, H. Homma, P.C. Chow, H. Reichert, S.C. Moss, Z. Barnea, S.S.P. Parkin and D. Cookson 10

Characterization of interface roughness in W/Si multilayers by high resolution diffuse X-ray scattering
T. Salditt, D. Lott, T.H. Metzger, J. Peisl, G. Vignaud, J.F. Legrand, G. Grübel, P. Høghøi and O. Schärpf 13

Probing interface roughness by X-ray scattering
D.K.G. de Boer and A.J.G. Leenaers 18

Growth-induced interface roughness of GaAs/AlAs-layers studied by X-ray scattering under grazing angles
U. Klemradt, M. Funke, M. Fromm, B. Lengeler, J. Peisl and A. Förster 27

Effect of roughness correlations in multilayers on Bragg peaks in X-ray diffuse scattering
V.M. Kaganer, S.A. Stepanov and R. Köhler 34

Characterization of Si/Ge interfaces by diffuse X-ray scattering in the region of total external reflection
J.-P. Schlomka, M.R. Fitzsimmons, R. Pynn, J. Stettner, O.H. Seeck, M. Tolan and W. Press 44

Thin polymer films on rough surfaces
M. Tolan, G. Vacca, J. Wang, S.K. Sinha, Z. Li, M.H. Rafailovich, J. Sokolov, A. Gibaud, H. Lorenz and J.P. Kotthaus 53

**Chapter 2. Growth phenomena**

Dynamic scaling phenomena in growth processes
M. Kardar 60

Orientation dependence of homoepitaxy: an in situ X-ray scattering study of Ag
W.C. Elliott, P.F. Miceli, T. Tse and P.W. Stephens 65

Cu island growth on Cu(1 1 0)
I.K. Robinson, K.L. Whiteaker and D.A. Walko 70

Off-specular reflectivity study of sputter-deposition of platinum during growth
H. You, K.G. Huang and R.T. Kampwirth 77

The growth of Sm on Mo(1 1 0) studied by surface X-ray diffraction
C.L. Nicklin, C. Norris, P. Steadman, J.S.G. Taylor and P.B. Howes 86

Epitaxial growth and lattice match of cobalt and nickel disilicides/Si(1 1 1) gold and cobalt doping of $NiSi_2$
J.-M. Gay, D. Mangelinck, P. Stocker, B. Pichaud and P. Gas 90

X-ray interface characterization of Ge $\delta$ layers on Si(0 0 1)
D. Bahr, J. Falta, G. Materlik, B.H. Müller and M. Horn-von Hoegen 96

Surface atomic ordering of $Cu_3Au$(0 0 1) above $T_c$
M. Kimura, J.B. Cohen, S. Chandavarkar and K.S. Liang 101

**Chapter 3. Faceting and reconstruction**

Faceting of stepped silicon(1 1 3) surfaces: Self assembly of nanoscale gratings
S.G.J. Mochrie, S. Song, M. Yoon, D.L. Abernathy and G.B. Stephenson 105

Chiral melting of the Si(1 1 3) (3 × 1) reconstruction
D.L. Abernathy, S. Song, K.I. Blum, R.J. Birgeneau and S.G.J. Mochrie 126

Surface X-ray diffraction on the potassium-induced reconstruction of the Ag(0 0 1) surface
H.L. Meyerheim, S. Pflanz, R. Schuster and I.K. Robinson 134

Identification of an incommensurate $FeAl_2$ overlayer on FeAl(1 1 0) using X-ray diffraction and reflectivity
A.P. Baddorf and S.S. Chandavarkar 141

**Chapter 4. Organic overlayers**

Epitaxy at the organic–inorganic interface
P. Fenter, P. Eisenberger, P. Burrows, S.R. Forrest and K.S. Liang 145

$C_{60}$–amine adducts at the air–water interface: A new class of Langmuir monolayers
D. Vaknin 152

The simultaneous analysis of multi-contrast neutron and X-ray grazing incidence reflection data from amphiphilic layers
E.M. Lee, J.E. Milnes and I.C. Wong 159

Neutron reflectometry study on an interface of octane and $D_2O$ at low surfactant ($C_{10}E_4$) concentration
U. Jeng, L. Esibov, M.L. Crow and A. Steyerl 168

Influence of order in thin smectic polymer films on the structure at the surface
G. Henn, M. Stamm, H. Poths, M. Rücker and J.P. Rabe 174

Neutron reflectivity study of structural changes in barium stearate Langmuir–Blodgett films during annealing
L. Feigin, O. Konovalov, D.G. Wiesler, C.F. Majkrzak, T. Berzina and V. Troitsky 185

**Chapter 5. Inorganic overlayers**

Interface and overlayer structure of epitaxial $CaF_2$ thin films on Si(1 1 1): an X-ray scattering study
K.G. Huang, J. Zegenhagen, J.M. Phillips and J.R. Patel 192

The growth and atomic structure of the Si(1 1 1) 7 × 7–Pb buried interface
K.A. Edwards, P.B. Howes, J.E. Macdonald, T. Hibma, T. Bootsma and M.A. James 201

Structure, translational state and morphology of the Ag/MgO(0 0 1) interface during its formation
P. Guénard, G. Renaud and B. Villette 205

Surface induced changes in the critical behavior of the $\beta_1$–$\beta_2$ phase transition in $V_2H$
R. Paniago, S. Schmid, T.H. Metzger, P.C. Chow, H. Reichert, S.C. Moss, J. Peisl and K.S. Liang 210

X-ray synchrotron radiation study of rare-gas film growth
F. Rieutord, R. Simon and B. Beau 215

**Chapter 6. Inorganic thin films and multilayers**

Increased thermal stability due to addition of Ge in B/Si(1 1 1) heterostructures
D.J. Tweet and K. Akimoto 218

Grazing incidence X-ray diffraction study of the InAs/GaAs interface
H. Rhan 226

Specular and diffuse reflectivity from thin films containing misfit dislocations
P.F. Miceli, J. Weatherwax, T. Krentsel and C.J. Palmstrøm 230

X-ray reflectivity study of thin film oxide superconductors
S.-W. Han, J.A. Pitney, P.F. Miceli, M. Covington, L.H. Greene, M.J. Godbole and D.H. Lowndes 235

**Chapter 7. Liquid surfaces and liquid/solid interfaces**

The structure and phase behavior of electrodeposited halides on single-crystal metal surfaces
B.M. Ocko, O.M. Magnussen, J.X. Wang, R.R. Adžić and Th. Wandlowski 238

In situ X-ray scattering study of the Pt(1 1 1)-solution interface: Ordered anion structures and their influence on copper underpotential deposition
C.A. Lucas, N.M. Marković, I.M. Tidswell and P.N. Ross 245

X-ray off-specular reflectivity studies of electrochemical pitting of Cu surfaces in sodium bicarbonate solution
Y.P. Feng, S.K. Sinha, C.A. Melendres and D.D. Lee 251

X-ray reflectivity studies of the surface structure of liquid metals
O.M. Magnussen, M.J. Regan, E.H. Kawamoto, B.M. Ocko, P.S. Pershan, N. Maskil, M. Deutsch, S. Lee, K. Penanen and L.E. Berman 257

Surface freezing and surface-phase behaviors in binary mixtures of alkanes
X.Z. Wu, B.M. Ocko, M. Deutsch, E.B. Sirota and S.K. Sinha 261

**Chapter 8. Complex fluids in confinement**

On the reflectivity of polymers: Neutrons and X-rays
T.P. Russell 267

X-ray and neutron diffuse scattering from multilayers of fatty acid salt molecules
R. Stömmer, U. Englisch, U. Pietsch and V. Holy 284

Structure under confinement in a smectic-A and lyotropic surfactant hexagonal phase
S.H.J. Idziak, I. Koltover, P. Davidson, M. Ruths, Y. Li, J.N. Israelachvili and C.R. Safinya 289

Interfacial scattering from surfactant monolayers in microemulsions
D.D. Lee, B.R. McClain, B.L. Carvalho, S.G.J. Mochrie, J.D. Litster, S.H. Chen, C.F. Majkrzak and S.K. Satija 296

Neutron reflection studies of phase separation and transesterification in thin film polymer blends
A.P.Y. Wong, A. Karim and C.C. Han 301

Neutron reflectivity measurements of homopolymer interfaces reinforced with random copolymers
R. Kulasekere, H. Kaiser, J.F. Ankner, T.P. Russell, H.R. Brown, C.J. Hawker and A.M. Mayes 306

"Over the horizon" SANS: Measurements on near-surface Poiseuille shear-induced ordering of dilute solutions of threadlike micelles
W.A. Hamilton, P.D. Butler, J.B. Hayter, L.J. Magid and P.J. Kreke 309

**Chapter 9. Segregation in polymer films**

Effects of mobile polymer concentration and chain length on the structure of tethered chains
L.-T. Lee, B.J. Factor, M.S. Kent and F. Rondelez 320

The effect of shear on the adsorption of non-ionic surfactants at the liquid–solid interface
J. Penfold, E. Staples, I. Tucker and G. Fragnetto 325

Comparative swelling of gels and polymer brush layers
A. Karim, J.F. Douglas, F. Horkay, L.J. Fetters and S.K. Satija 331

Neutron reflectivity of end grafted polymers in poor solvent: Kinetic effects
D. Perahia, D.G. Wiesler, S.K. Satija, L.J. Fetters, S.K. Sinha and G.S. Grest 337

**Chapter 10. Magnetism of thin films and multilayers**

Neutron scattering studies of magnetic thin films and multilayers
C.F. Majkrzak 342

Long-range exchange interactions in epitaxial layered magnetic structures
P. Grünberg, J.A. Wolf and R. Schäfer 357

Correlation between non-collinear exchange coupling and interface structure in Fe/Cr(0 0 1) superlattices
A. Schreyer, J.F. Ankner, M. Schäfer, H. Zabel, C.F. Majkrzak and P. Grünberg 366

Neutron diffraction and reflectivity studies of the Cr Néel transition in Fe/Cr(0 0 1) superlattices
E.E. Fullerton, S. Adenwalla, G.P. Felcher, K.T. Riggs, C.H. Sowers, S.D. Bader and J.L. Robertson 370

Magnetic and structural properties of Fe/Nb multilayers
Ch. Rehm, F. Klose, D. Nagengast, B. Pietzak, H. Maletta and A. Weidinger 377

Magnetic depth profile of Au/Fe/Ni trilayers
Y. Li, C. Polaczyk, F. Klose, Ch. Rehm, H. Maletta, D. Riegel, G.P. Felcher and S. Adenwalla 382

Polarized neutron reflectometry studies of magnetic oxidic $Fe_3O_4$/NiO and $Fe_3O_4$/CoO multilayers
A.R. Ball, H. Fredrikze, D.M. Lind, R.M. Wolf, P.J.H. Bloemen, M.Th. Rekveldt and P.J. van der Zaag 388

Polarized neutron reflectometry on metal evaporated videotapes
A. van der Graaf, H. Fredrikze and M.Th. Rekveldt 393

Observation of two length scales above $T_N$ in a holmium thin film
P.M. Gehring, A. Vigliante, D.F. McMorrow, D. Gibbs, C.F. Majkrzak, G. Helgesen, R.A. Cowley, R.C.C. Ward and M.R. Wells 398

**Chapter 11. Magnetic and anomalous X-ray scattering**

Grazing-incidence X-ray magnetic scattering studies of $UO_2$(0 0 1) surfaces
G.M. Watson, D. Gibbs, G.H. Lander, H. Matzke, B.D. Gaulin, L.E. Berman and W. Ellis 405

Kerr effect in X-ray grazing incidence geometry
V.M. Matveev and V.V. Matveev 408

Resonant X-ray reflectivity study of Fe/Cr superlattices
J. Bai, E.E. Fullerton and P.A. Montano 411

Anomalous dispersion X-ray reflectometry for model-independent determination of Al/C multilayer structures
T. Ohkawa, Y. Yamaguchi, O. Sakata, M.K. Sanyal, A. Datta, S. Banerjee and H. Hashizume 416

Structure of oxide overlayer studied by energy dispersive X-ray diffraction
W. Dmowski, T. Egami, R. Gorte and J. Vohs 420

**Chapter 12. Standing waves**

Adsorbate structure and vibrations on the Bi/Si(0 0 1)-(1 × 2) surface
P.F. Lyman, Y. Qian, T.-L. Lee and M.J. Bedzyk 426

Thermal vibration amplitudes and structure of Sb on Si(0 0 1) by X-ray standing waves
Y. Qian, P.F. Lyman, T. Lee and M.J. Bedzyk 430

The use of X-ray standing waves and evanescent-wave emission to study buried strained-layer heterostructures
T.-L. Lee, Y. Qian, P.F. Lyman, J.C. Woicik, J.G. Pellegrino and M.J. Bedzyk 437

Phase-sensitive multiple-diffraction studies of single crystals
M.V. Kovalchuk, A. Kazimirov, V. Kohn, A. Kreines and L. Samoilova 445

Diffraction of neutron standing waves in thin films with resonance enhancement
H. Zhang, S.K. Satija, P.D. Gallagher, J.A. Dura, K. Ritley, C.P. Flynn and J.F. Ankner 450

Diffraction of neutron standing waves in thin films
H. Zhang 455

**Chapter 13. Instrumentation and novel methods**

Electron-density maps for the Si(1 1 1) $7 \times 7$ surface calculated with the maximum-entropy technique using X-ray and electron-diffraction data
C.A.M. Carvalho, H. Hashizume, A.W. Stevenson and I.K. Robinson 469

X-ray diffraction in quantum-well structures
E. Zolotoyabko, Y. Finkelstein, M. Blumina and D. Fekete 487

Observation of the Zeeman splitting for neutrons reflected by magnetic layers
G.P. Felcher, S. Adenwalla, V.O. De Haan and A.A. Van Well 494

Neutron reflectivity measurements of titanium–beryllium multilayers
A.E. Munter, B.J. Heuser and K.M. Skulina 500

Conceptional design of a flexible neutron reflectometer at 'SINQ'
D. Clemens 507

**Chapter 14. Inverse problem in reflectometry**

Aspects of the inverse scattering problem in neutron specular reflection
R. Lipperheide, G. Reiss, H. Leeb and S.A. Sofianos 514

Exact determination of the neutron reflection amplitude or phase
C.F. Majkrzak and N.F. Berk 520

Toward the solution of the inverse problem in neutron reflectometry
V.O. de Haan, A.A. van Well, P.E. Sacks, S. Adenwalla and G.P. Felcher 524

Phase effects in neutron reflection by microemulsions and polymers
G. Reiss 533

Moments analysis of X-ray reflection profiles
F. Rieutord, A. Braslau, R. Simon, H.J. Lauter and V. Pasyuk 538

Global minimization in reconstruction of the scattering-length density profile by X-ray reflectivity data
I.I. Samoilenko, B.M. Shchedrin and L.A. Feigin 542

List of Contributors 547

Subject Index 551